

Notice of References Cited	Application/Control No. 10/597,136		Applicant(s)/Patent Under Reexamination KITAMURA ET AL.	
	Examiner Meiya Li		Art Unit 2811	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2004/0066630 A1	04-2004	Whittenburg et al.	361/719
*	C	US-2004/0118501 A1	06-2004	Chiu et al.	156/064
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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